

Status of x-ray  
calibration efforts

Andreas Ritter

Calibration with  
Si-diode

Calibration with  
thermoluminescent  
dosimeter (TLD)

Measurement of  
x-ray spectra with  
scintillator

Conclusions and  
outlook

# Status of x-ray calibration efforts

## Different methods and results

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# Motivation

Status of x-ray  
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Conclusions and  
outlook

- Some groups use our x-ray tube to irradiate their chips, sensors, semiconductor structures,...
- Calibration was done couple of years ago, we wanted to refresh calibration and crosscheck our data with an alternative method

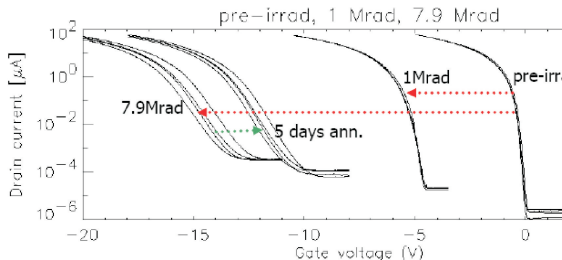


Figure: Measurement done by MPI Halbleiterlabor

# Measurement with Diode I

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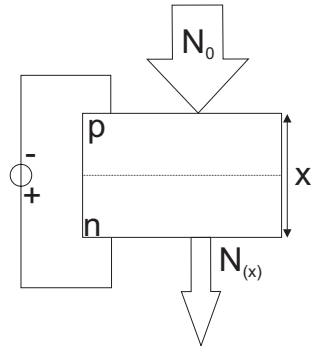
Conclusions and  
outlook

- Silicon Diode is totally depleted
- $\gamma$ 's are absorbed via the photoelectric effect

$$N(x) = N_0 e^{-\sigma(E)\rho x}$$

$\sigma$  = mass attenuation  
coefficient,  $\rho$  = density

- Absorbed  $\gamma$ 's create electron/hole pairs
- Every electron/hole pair represents 3.6 eV



# Measurement with Diode II

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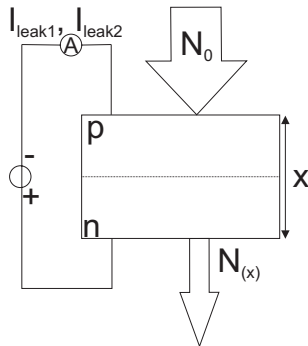
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Conclusions and  
outlook

- Leakage Current rises due to irradiation
- $I_{Leak} \Rightarrow$  electron/hole pairs per sec.  $\Rightarrow$  Power deposited in Si-diode
- With mass of irradiated volume and power being absorbed in material  $\Rightarrow$  Dose rate deposited in material



# Measurement with Diode III

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Conclusions and  
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- At 60 kV, 20 mA and 155 mm distance, we have a doserate of  $\frac{D}{t} = 66.6 \frac{\text{krad}}{\text{h}}$  in  $300 \mu\text{m Si}$
- Also the smaller the distance, the higher the dose rate  $\frac{D}{t} \propto \frac{1}{r^2} + \text{const.}$
- To determine the energy deposited on surfaces the energy spectrum is required

# Calibration with thermoluminescent dosimeter (TLD)

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Conclusions and  
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- TLDs provided by Forschungszentrum Karlsruhe (FZK)
- TLD material emits light after exposure to radiation
- Calibration is done via heating the TLDs and counting emitting photons
- Absolute calibration is complex and requires known spectra
- TLDs of FZK are calibrated to “N-60” spectrum <sup>1</sup>

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<sup>1</sup>N-60 spectrum is a specified spectra of the ISO-4037 standard

# N-60 spectrum

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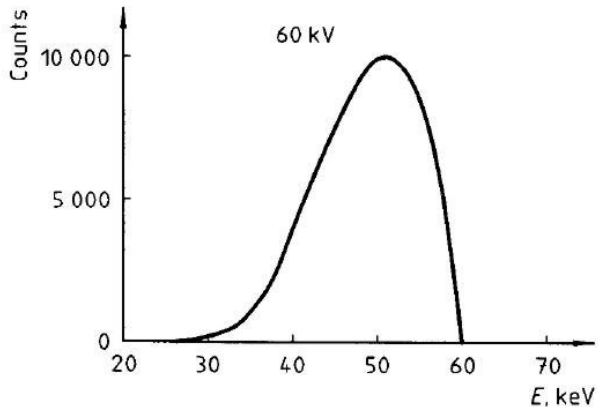
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# Measurement of x-ray spectra with scintillator

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- Using a plastic scintillator "Ne 102 A" with photomultiplier
- Radioactive source with known  $\gamma$  peak needed to calibrate x-ray spectra, or calibration with maximum voltage of electron acceleration potential
- Results have to be combined with total mass attenuation coefficient for "real" spectra



# Energy spectrum of scintillator

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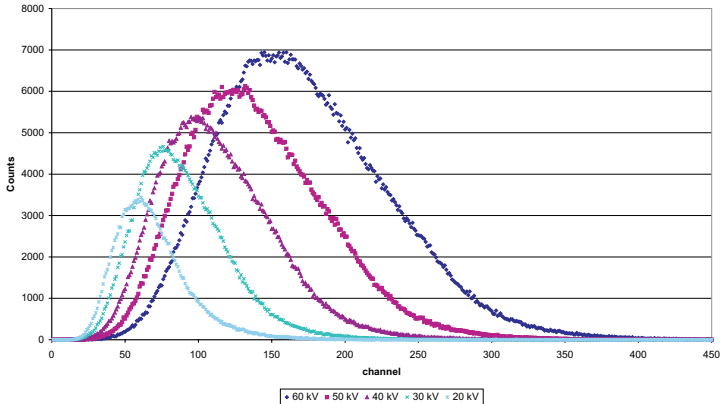
Calibration with Si-diode

Calibration with thermoluminescent dosimeter (TLD)

Measurement of x-ray spectra with scintillator

Conclusions and outlook

Counts of scintillator at x-ray radiation (without background)



# Energy spectrum of scintillator (corrected)

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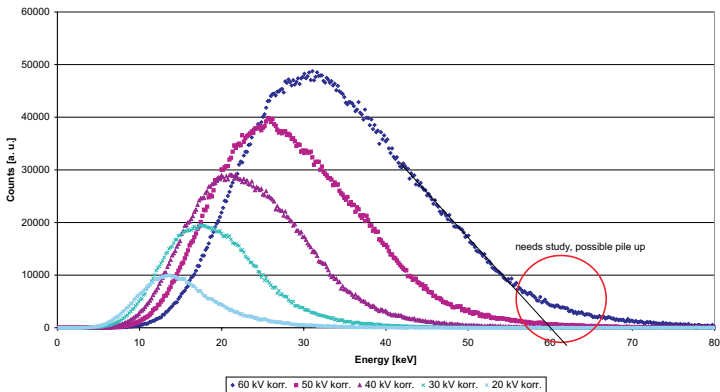
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Counts of scintillator at x-ray radiation (corrected with mass attenuation coefficient)  
Preliminary data!



# Conclusions and outlook

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- Diode measurement redone, new dose rate coefficient aquired
- TLD measurement done by FZK, needs our spectra to determine actual dose rate
- Spectra themselves are useful for irradiation studies (how much energy is deposited in surface structures/ $SiO_2$ )